TBCALC: The Technical Document
Version 1.0

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1 Introduction

This documentation describes briefly the technical details and theoretical basis of TBCALC package used to calculate the X-ray diffraction curves of toroidally bent, Johann-type crystal analysers. For comprehensive explanation, please refer to [1].

2 Calculation of the reflectivity curves

As formally shown [2], the effect of a constant component in a strain field to the diffraction curve can be taken into account by a applying a shift, either in energy or angle domain, to the Takagi-Taupin curve calculated without it. Since for toroidally bent crystal analysers the total strain field can be divided into a sum of depth-dependent and transversally varying parts, this allows efficient calculation of the reflectivity curves even for very large wafers. The calculation is summed up in the following steps:

- Compute the 1D Takagi-Taupin curve for the depth-dependent component of the strain field. TBCALC uses another Python package PYTTE for this.
- Calculate distribution the energy or angle shifts due to the transversally varying component. The Johann error can be included in this part.
- Convolve the 1D TT-curve with the shift distribution to obtain the full reflectivity curve of the analyser.
- Convolve the result with the incident bandwidth, if needed.

2.1 Depth-dependent Takagi-Taupin curve

The 1D TT-curve is calculated using PyTTE. In v. 1.0 of TBCALC it is assumed that the main axes of curvature of TBCA:s are along the meridional and sagittal directions with respect to the diffraction plane and coincide, respectively, with the x- and y-axes of the Cartesian system used in the code and the manuscript [1]. By default, the internal anisotropic compliance matrices[1] are used for elastic parameters and XRAYLIB[2] for crystallograpic parameters and structure factors.

[1] Values from CRC Handbook of Chemistry and Physics, 82nd edition (2001)
[2] `https://github.com/tschoonj/xraylib`

2.2 Transverse stress and strain tensor fields

For convenience, this section lists the equations for the transverse stress tensor and the strain it causes. Refer to [1] for the derivation and discussion.

2.2.1 Isotropic circular

The components of the transverse stress tensor of an isotropic circular wafer with the diameter L and meridional and sagittal bending radii R_1 and R_2, respectively, are

$$\sigma_{xx} = \frac{E}{16R_1R_2}\left(\frac{L^2}{4} - x^2 - 3y^2\right) \qquad \sigma_{xy} = \frac{E}{8R_1R_2}xy \qquad \sigma_{yy} = \frac{E}{16R_1R_2}\left(\frac{L^2}{4} - 3x^2 - y^2\right) \tag{1}$$

the corresponding strain tensor components

$$u_{xx} = \frac{1}{16R_1R_2}\left[(1-\nu)\frac{L^2}{4} - (1-3\nu)x^2 - (3-\nu)y^2\right] \tag{2}$$

$$u_{yy} = \frac{1}{16R_1R_2}\left[(1-\nu)\frac{L^2}{4} - (1-3\nu)y^2 - (3-\nu)x^2\right] \tag{3}$$

$$u_{xy} = \frac{1+\nu}{8R_1R_2}xy \qquad u_{xz} = u_{yz} = 0 \qquad u_{zz} = \frac{\nu}{4R_1R_2}\left(x^2 + y^2 - \frac{L^2}{8}\right) \tag{4}$$

and the contact force per unit area

$$P = \frac{Ed}{16R_1^2R_2^2}\left[(3R_1 + R_2)\,x^2 + (R_1 + 3R_2)\,y^2 - (R_1 + R_2)\,\frac{L^2}{4}\right]. \tag{5}$$

2.2.2 Anisotropic circular

The stretching stress tensor components are

$$\sigma_{xx} = \frac{E'}{16R_1R_2}\left(\frac{L^2}{4} - x^2 - 3y^2\right) \quad \sigma_{yy} = \frac{E'}{16R_1R_2}\left(\frac{L^2}{4} - 3x^2 - y^2\right) \quad \sigma_{xy} = \frac{E'}{8R_1R_2}xy \tag{6}$$

where

$$E' = \frac{8}{3(S_{11} + S_{22}) + 2S_{12} + S_{66}}, \tag{7}$$

the corresponding strain tensor

$$u_{xx} = \frac{E'}{16R_1R_2}\left[(S_{11} + S_{12})\frac{L^2}{4} - (S_{11} + 3S_{12})x^2 - (3S_{11} + S_{12})y^2 + 2S_{16}xy\right] \tag{8}$$

$$u_{yy} = \frac{E'}{16R_1R_2}\left[(S_{21} + S_{22})\frac{L^2}{4} - (S_{21} + 3S_{22})x^2 - (3S_{21} + S_{22})y^2 + 2S_{26}xy\right] \tag{9}$$

$$u_{zz} = \frac{E'}{16R_1R_2}\left[(S_{31} + S_{32})\frac{L^2}{4} - (S_{31} + 3S_{32})x^2 - (3S_{31} + S_{32})y^2 + 2S_{36}xy\right] \tag{10}$$

$$u_{xz} = \frac{E'}{32R_1R_2}\left[(S_{41} + S_{42})\frac{L^2}{4} - (S_{41} + 3S_{42})x^2 - (3S_{41} + S_{42})y^2 + 2S_{46}xy\right] \tag{11}$$

$$u_{yz} = \frac{E'}{32R_1R_2}\left[(S_{51} + S_{52})\frac{L^2}{4} - (S_{51} + 3S_{52})x^2 - (3S_{51} + S_{52})y^2 + 2S_{56}xy\right] \tag{12}$$

$$u_{xy} = \frac{E'}{32R_1R_2}\left[(S_{61} + S_{62})\frac{L^2}{4} - (S_{61} + 3S_{62})x^2 - (3S_{61} + S_{62})y^2 + 2S_{66}xy\right] \tag{13}$$

and the contact force per unit area

$$P = \frac{E'd}{16R_1^2R_2^2}\left[(3R_1 + R_2)\,x^2 + (R_1 + 3R_2)\,y^2 - (R_1 + R_2)\,\frac{L^2}{4}\right]. \tag{14}$$

References

[1] Ari-Pekka Honkanen and Simo Huotari. General procedure for calculating the elastic deformation and x-ray diffraction properties of toroidally and spherically bent crystal wafers. In preparation, 2020.

[2] Ari-Pekka Honkanen, Giulio Monaco, and Simo Huotari. A computationally efficient method to solve the takagi–taupin equations for a large deformed crystal. *Journal of Applied Crystallography*, 49(4):1284–1289, jul 2016. doi:10.1107/s1600576716010402.